TPIC3302 3-CHANNEL COMMON-DRAIN POWER DMOS ARRAY

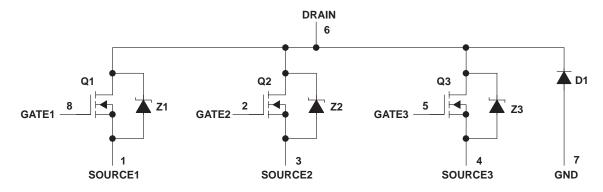
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The TPIC3302 is a monolithic power DMOS array that consists of three electrically isolated N-channel enhancement-mode DMOS transistors configured with a common drain and open sources. The TPIC3302 is offered in a standard eight-pin small-outline surface-mount (D) package.

The TPIC3302 is characterized for operation over the case temperature range of -40°C to 125°C.

schematic



absolute maximum ratings over operating case temperature range (unless otherwise noted)†

Drain-to-source voltage, V _{DS}	60 V
Source-to-GND voltage	100 V
Drain-to-GND voltage	100 V
Gate-to-source voltage, V _{GS}	±20 V
Continuous drain current, each output, all outputs on, T _C = 25°C	1 A
Continuous source-to-drain diode current	1 A
Pulsed drain current, each output, $T_C = 25^{\circ}C$ (see Note 1 and Figure 6)	5 A
Single-pulse avalanche energy, T _C = 25°C, E _{AS} (see Figure 4)	9 mJ
Continuous total power dissipation at (or below) T _C = 25°C	0.95 W
Operating virtual junction temperature range, TJ	
Operating case temperature range, T _C	–40°C to 125°C
Storage temperature range, T _{stq}	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: Pulse duration = 10 ms, duty cycle = 2%



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electrical characteristics, $T_C = 25^{\circ}C$ (unless otherwise noted)

	PARAMETER	TEST CONDI	TIONS	MIN	TYP	MAX	UNIT
V _{(BR)DSX}	Drain-to-source breakdown voltage	$I_D = 250 \mu\text{A},$	$V_{GS} = 0$	60			V
V _{GS(th)}	Gate-to-source threshold voltage	$I_D = 1 \text{ mA},$	$V_{DS} = V_{GS}$	1.5	1.85	2.2	V
V _(BR)	Reverse drain-to-GND breakdown voltage (across D1)	Drain-to-GND curren	t = 250 μA	100			V
V _{DS(on)}	Drain-to-source on-state voltage	I _D = 1 A, See Notes 2 and 3	$V_{GS} = 10 V$,		0.4	0.475	V
VF	Forward on-state voltage, GND-to-drain	I _D = 1 A, See Notes 2 and 3			2		V
V _F (SD)	Forward on-state voltage, source-to-drain	I _S = 1 A, See Notes 2 and 3	$V_{GS} = 0$,		0.9	1.1	V
	VDS = 4	V _{DS} = 48 V,	T _C = 25°C		0.05	1	
IDSS	Zero-gate-voltage drain current	$V_{GS} = 0$	T _C = 125°C		0.5	10	μΑ
IGSSF	Forward gate current, drain short circuited to source	V _{GS} = 16 V,	$V_{DS} = 0$		10	100	nA
IGSSR	Reverse gate current, drain short circuited to source	V _{SG} = 16 V,	$V_{DS} = 0$		10	100	nA
1	Lookage current drain to CND	V- 49 V	$T_C = 25^{\circ}C$		0.05	1	^
llkg	Leakage current, drain-to-GND	V _R = 48 V	T _C = 125°C		0.5	10	μΑ
*	Static discipute courses on state registeres	V _{GS} = 10 V, I _D = 1 A,	T _C = 25°C		0.4	0.475	0
rDS(on)	Static drain-to-source on-state resistance	See Notes 2 and 3 and Figures 6 and 7	T _C = 125°C	0.63	0.7	Ω	
9fs	Forward transconductance	V _{DS} = 10 V, See Notes 2 and 3	$I_D = 0.5 A,$	0.85	1.02	·	S
C _{iss}	Short-circuit input capacitance, common source				115	145	
C _{oss}	Short-circuit output capacitance, common source	$V_{DS} = 25 V$,	$V_{GS} = 0$,		60	75	pF
C _{rss}	Short-circuit reverse-transfer capacitance, common source	f = 1 MHz			30	40	pΓ

source-to-drain diode characteristics, $T_C = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS			TYP	MAX	UNIT
trr(SD)	Reverse-recovery time	$I_S = 0.5 \text{ A}, V_{GS} = 0,$	V _{DS} = 48 V,		35		ns
Q _{RR}	Total diode charge	di/dt = 100 A/μs,	See Figure 1		0.03		μC

GND-to-drain diode characteristics, $T_C = 25^{\circ}C$ (see schematic, D1)

	PARAMETER	TEST CON	MIN	TYP	MAX	UNIT	
t _{rr}	Reverse-recovery time	IF = 0.5 A,	V _{DS} = 48 V,		90		ns
Q _{RR}	Total diode charge	di/dt = 100 A/μs,	See Figure 1	_	0.2		μС

NOTES: 2. Technique should limit T_J − T_C to 10°C maximum, pulse duration ≤5 ms.

3. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

resistive-load switching characteristics, T_C = 25°C

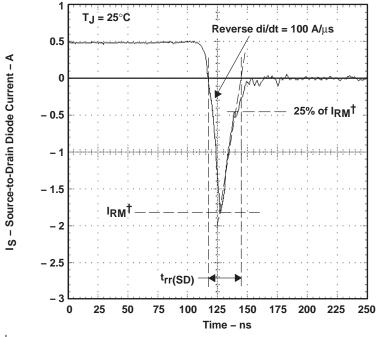
PARAMETER TEST CO			TEST CONDITIO	NS	MIN	TYP	MAX	UNIT
td(on)	Turn-on delay time					21	42	
td(off)	Turn-off delay time	V_{DD} = 25 V, R_L = 50 Ω , t_{dis} = 10 ns, See Figure 2	$t_{en} = 10 \text{ ns},$		20	40		
t _r	Rise time		$t_{dis} = 10 \text{ ns},$	t _{dis} = 10 ns, See Figure 2			5	10
tf	Fall time]				13	26	
Qg	Total gate charge					3.1	3.8	
Q _{gs(th)}	Threshold gate-to-source charge	V _{DS} = 48 V, I _D See Figure 3		$V_{GS} = 10 V$		0.4	0.5	nC
Q _{gd}	Gate-to-drain charge					1.3	1.6	
L _D	Internal drain inductance					5		- II
LS	Internal source inductance					5		nΗ
Rg	Internal gate resistance					0.25		Ω

thermal resistance

PARAMETER TEST CONDIT		TEST CONDITIONS		MIN	TYP	MAX	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	All outputs with equal power	See Note 4		130		°C/W
$R_{\theta JP}$	Junction-to-pin thermal resistance	All outputs with equal power,	See Note 4		44		C/VV

NOTE 4: Package mounted on an FR4 printed-circuit board with no heat sink

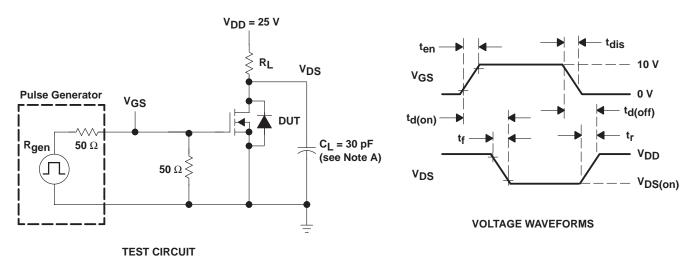
PARAMETER MEASUREMENT INFORMATION



[†]I_{RM} = maximum recovery current

Figure 1. Reverse-Recovery-Current Waveform of Source-to-Drain Diode

PARAMETER MEASUREMENT INFORMATION



NOTE A: C_L includes probe and jig capacitance.

Figure 2. Resistive-Switching Test Circuit and Voltage Waveforms

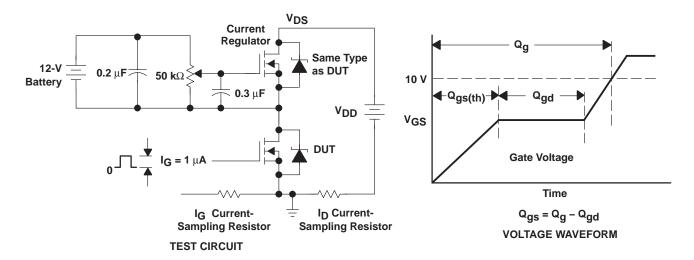
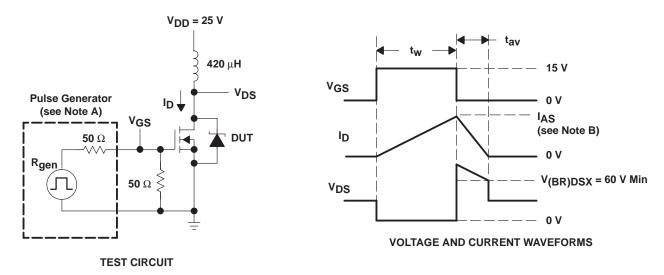


Figure 3. Gate-Charge Test Circuit and Voltage Waveform

PARAMETER MEASUREMENT INFORMATION



NOTES: A. The pulse generator has the following characteristics: $t_r \le 10$ ns, $t_f \le 10$ ns, $Z_O = 50$ Ω .

B. Input pulse duration (t_W) is increased until peak current $I_{AS} = 5$ A.

Energy test level is defined as E
$$_{\mbox{AS}} = \frac{\mbox{I}_{\mbox{AS}} \times \mbox{V}_{\mbox{(BR)}\mbox{DSX}} \times \mbox{t}_{\mbox{av}}}{2} = \mbox{9 mJ}.$$

Figure 4. Single-Pulse Avalanche-Energy Test Circuit and Waveforms

TYPICAL CHARACTERISTICS

Figure 5

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE vs JUNCTION TEMPERATURE

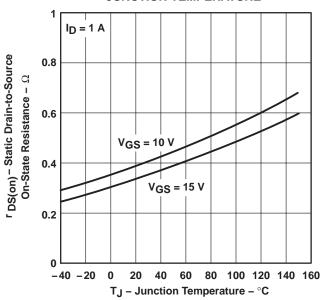


Figure 6

TYPICAL CHARACTERISTICS

5

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE

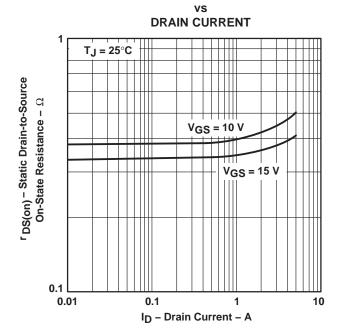


Figure 7

15 V 10 V ∆V_{GS} = 0.2 V T_J = 25°C Unless Otherwise 4 Noted D- Drain Current - A VGS = 5 V 3 2 $V_{GS} = 4 V$ 1 $V_{GS} = 3 V$ 0 1 2 3 4 5 6 8 9 10 V_{DS} - Drain-to-Source Voltage - V

DRAIN CURRENT

DRAIN-TO-SOURCE VOLTAGE

Figure 8

DISTRIBUTION OF FORWARD TRANSCONDUCTANCE

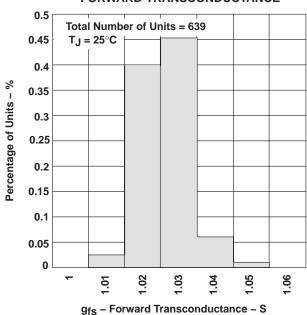


Figure 9

DRAIN CURRENT vs GATE-TO-SOURCE VOLTAGE

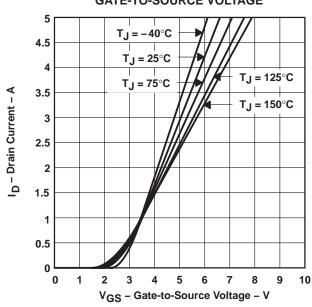


Figure 10

TYPICAL CHARACTERISTICS

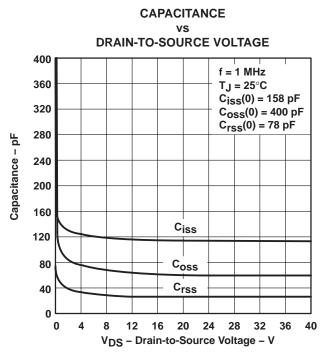


Figure 11

DRAIN-TO-SOURCE VOLTAGE AND GATE-TO-SOURCE VOLTAGE

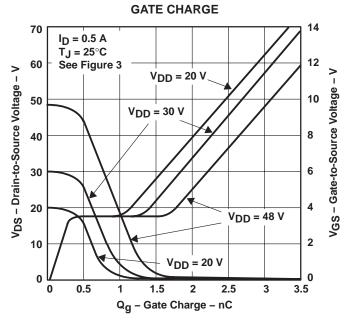


Figure 13

SOURCE-TO-DRAIN DIODE CURRENT SOURCE-TO-DRAIN VOLTAGE

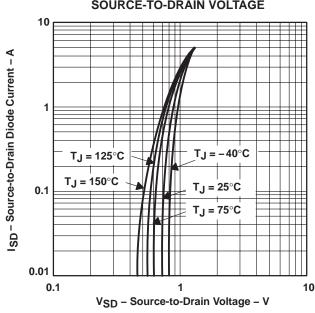


Figure 12

REVERSE-RECOVERY TIME

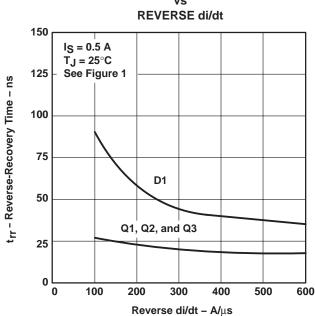
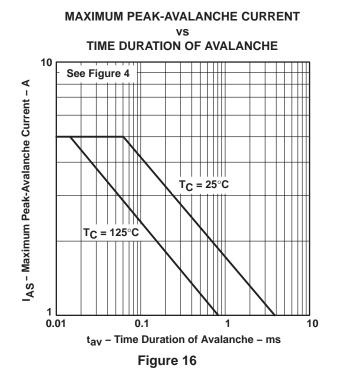


Figure 14

THERMAL INFORMATION

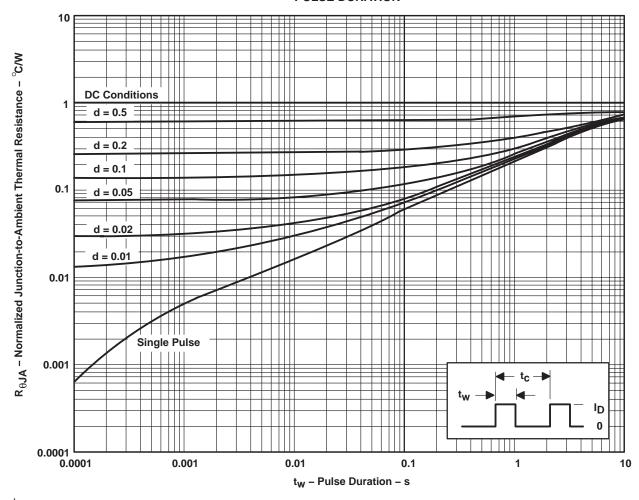
†Less than 0.1 duty cycle

Figure 15



THERMAL INFORMATION

D PACKAGE[†] NORMALIZED JUNCTION-TO-AMBIENT THERMAL RESISTANCE vs PULSE DURATION



† Device mounted on FR4 printed-circuit board with no heat sink

 $\begin{aligned} \text{NOTES:} \quad Z_{\theta A}(t) &= r(t) \; R_{\theta JA} \\ \quad t_W &= \text{pulse duration} \\ \quad t_C &= \text{cycle time} \\ \quad d &= \text{duty cycle} = t_W/t_C \end{aligned}$

Figure 17



PACKAGE OPTION ADDENDUM

8-Apr-2005

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp (3)
TPIC3302D	OBSOLETE	SOIC	D	8	TBD	Call TI	Call TI

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AA.



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